

STD26NF10

N-channel 100V - 0.033Ω - 25A - DPAK Low gate charge STripFET™ II Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD26NF10	100V	< 0.038Ω	25A

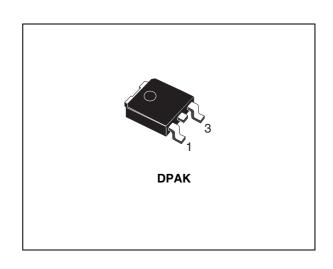
- Exceptional dv/dt capability
- Application oriented characterization
- 100% avalanche tested
- Application oriented characterization

Description

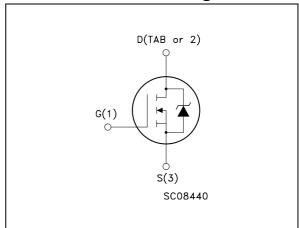
This Power MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is intended for any application with low gate charge drive requirements.

Applications

- Switching application
 - Automotive



Internal schematic diagram



Order code

Part number	Marking	Package	Packaging	
STD26NF10	D26NF10	DPAK	Tape & reel	

Contents STD26NF10

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STD26NF10 Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	100	V
V _{DGR}	Drain-gate voltage (R _{GS} = 20 kΩ)	100	V
V _{GS}	Gate- source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25°C	25	Α
I _D	Drain current (continuous) at T _C = 100°C	21	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	100	Α
P _{tot}	Total dissipation at T _C = 25°C	100	W
	Derating Factor	0.67	W/°C
dv/dt ⁽³⁾	Peak diode recovery avalanche energy	13	V/ns
E _{AS} (4)	Single pulse avalanche energy	480	mJ
T _{stg}	Storage temperature	-55 to 175	°C
Tj	Max. operating junction temperature	-55 10 175	

- 1. Current limited by package
- 2. Pulse width limited by safe operating area.
- 3. $I_{SD} \le 35A$, di/dt $\le 300A/\mu s$, $V_{DD} = V(BR)DSS$, $T_j \le T_{JMAX}$
- 4. Starting $T_i = 25$ °C, $I_D = 12.5 \text{A V}_{DD} = 50 \text{V}$

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	1.5	°C/W
Rthj-amb	Thermal resistance junction-to ambient max	100	°C/W
T _J	Maximum lead temperature for soldering purpose	300	°C

Electrical characteristics STD26NF10

2 Electrical characteristics

(T_{CASE} =25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	100			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating, T_{C} = 125°C			1 10	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	٧
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 12.5A$		0.033	0.038	Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V, I _D = 12.5A		20		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1MHz,$ $V_{GS} = 0$		1550 220 95		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 50V, I_{D} = 12.5A R_{G} = 4.7 Ω V_{GS} = 10V (see <i>Figure 12</i>)		17 60 60 15		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 80V, I_{D} = 12.5A,$ $V_{GS} = 10V, R_{G} = 4.7\Omega$ (see <i>Figure 13</i>)		55 12 20		nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%.

Table 5. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				25 100	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 25A, V _{GS} = 0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 25A$, di/dt = 100A/ μ s, $V_{DD} = 50V$, $T_{j} = 150$ °C (see <i>Figure 14</i>)		88 317 7.2		ns nC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STD26NF10

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

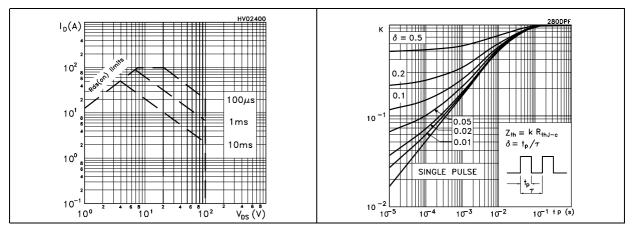


Figure 3. Output characteristics

Figure 4. Transfer characteristics

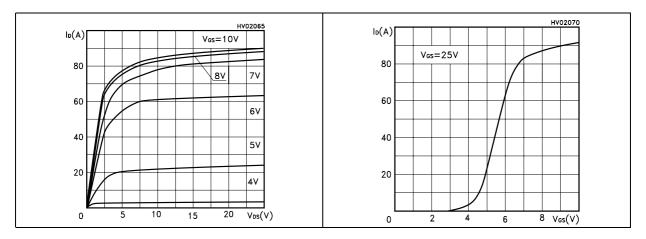
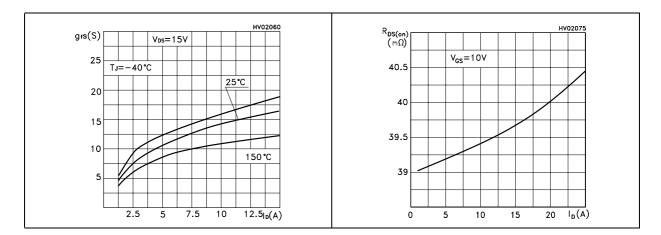


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



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Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations

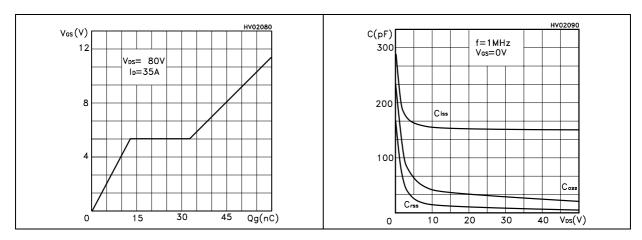


Figure 9. Normalized gate threshold voltage Figure 10. Normalized on resistance vs. vs. temperature temperature

150 T√℃)

Nos(th)
(norm)

1.1

1.0

0.9

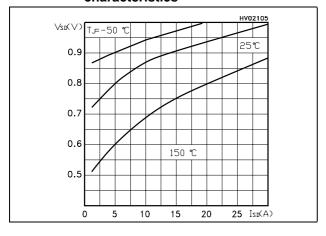
Figure 11. Source-drain diode forward characteristics

0

-50

0.7

0.6



50

57

Test circuit STD26NF10

3 Test circuit

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

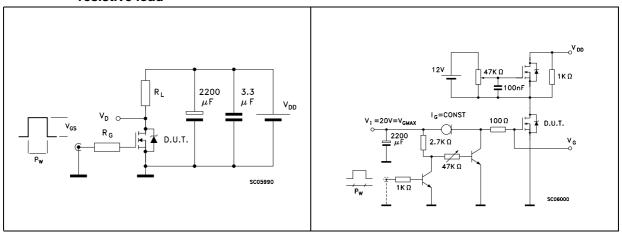


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped Inductive load test circuit

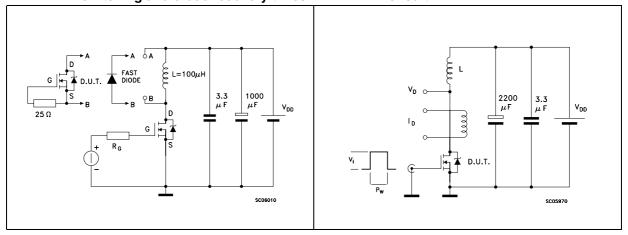
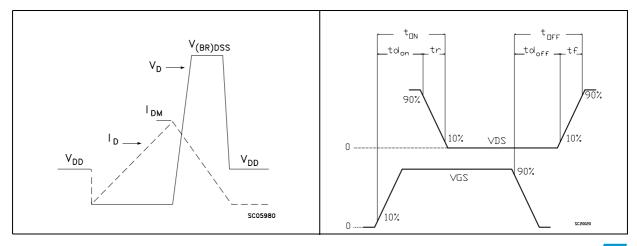


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



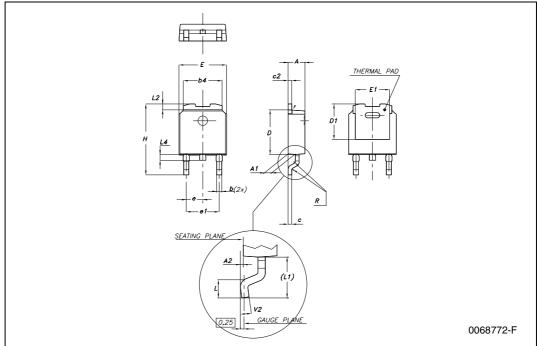
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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

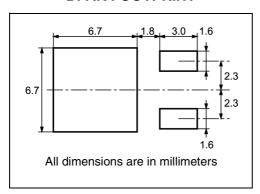
DPAK MECHANICAL DATA

DIM	mm.	mm.		inch		
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°

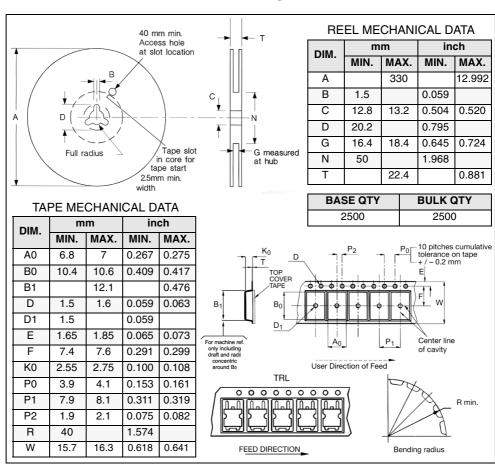


5 Packing mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



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Revision history STD26NF10

6 Revision history

Table 6. Revision history

Date	Revision	Changes
20-Apr-2007	1	First release

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